

Search Notes**Application/Control No.**

10/768,667

Examiner

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Applicant(s)/Patent under Reexamination

SCHUHRKE ET AL.

Art Unit

2625

SEARCHED

Class	Subclass	Date	Examiner
358	1.9	3/16/2008	AV
	518		
	504		
	509		
	512		
	527		
	1.1		
	3.27		
358	1.13		
382	167		
	162		
382	165	3/16/2008	AV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	3/16/2008	AV
East	3/17/2008	AV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner